

N-Channel Super Junction Power MOSFET $\, \mathrm{I\!V}$

General Description

The series of devices use advanced trench gate super junction technology and design to provide excellent Rds(ON) with low gate charge. This super junction MOSFET fits the industry's AC-DC SMPS requirements for PFC, AC/DC power conversion, and industrial power applications.

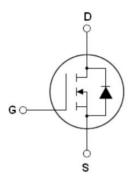
Featu	res
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- New technology for high voltage device
- Low on-resistance and low conduction losses
- ●Small package
- ●Ultra Low Gate Charge cause lower driving requirements
- ●100% Avalanche Tested
- ROHS compliant

Application

- Power factor correction (PFC)
- Switched mode power supplies(SMPS)
- Uninterruptible Power Supply (UPS)

V _{DS min@Tjmax}	550	V
R _{DS(ON)TYP} .	520	mΩ
I_D	6.3	Α
Qg	9.5	nC



Schematic diagram

♦ Intrinsic fast-recovery body diode

Package Marking And Ordering Information

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Device	Device Package	Marking
NCE50NF600F	TO-220F-3L	NCE50NF600F



TO-220F

V1.0

Table 1. Absolute Maximum Ratings (T_c=25℃)

Parameter	Symbol	Value	Unit
Drain-Source Voltage (Vgs=0V)	V _{DS}	500	V
Gate-Source Voltage (VDS=0V) ,AC (f>1 Hz)	Vgs	± 30	V
Gate-Source Voltage (V _{DS} =0V) ,DC	Vgs	± 20	V
Continuous Drain Current at Tc=25°C	I _{D (DC)}	6.3	А
Continuous Drain Current at Tc=100°C	I _{D (DC)}	4.41	А
Pulsed drain current (Note 1)	I _{DM (pluse)}	18.9	А
Maximum Power Dissipation(Tc=25℃)	P _D	30.9	W
Derate above 25°C		0.21	W/°C
Single pulse avalanche current (Note 2)	I _{AS}	2.5	А
Reverse diode dv/dt, V _{DS} ≤480 V,I _{SD} <i<sub>D</i<sub>	dv/dt	15	V/ns
Drain Source voltage slope,V _{DS} ≤480 V	dv/dt	50	V/ns
Operating Junction and Storage Temperature Range	T _J ,T _{STG}	-55+175	°C

V1.0



Table 2. Thermal Characteristic

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case (Maximum)	R _{thJC}	4.85	°C /W
Thermal Resistance, Junction-to-Ambient (Maximum)	R _{thJA}	62	°C /W

Table 3. Electrical Characteristics (TA=25°Cunless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
On/off states				•		
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250uA	500			V
Zero Gate Voltage Drain Current(Tc=25°ℂ)	I _{DSS}	V _{DS} =500V,V _{GS} =0V			10	μA
Zero Gate Voltage Drain Current(Tc=125℃)	I _{DSS}	V _{DS} =500V,V _{GS} =0V			300	μA
Gate-Body Leakage Current	I _{GSS}	$V_{GS}=\pm20V, V_{DS}=0V$			±200	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS},I_{D}=250uA$	3		5	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =3A		520	600	mΩ
Dynamic Characteristics				•		
Gate Resistance	Rg	F=1MHZ, D-S short		35		Ω
Input Capacitance	C _{iss}	., 50,4,4, 6,4		317		pF
Output Capacitance	Coss	V_{DS} =50V, V_{GS} =0V,		22		pF
Reverse Transfer Capacitance	C _{rss}	F=1MHz		2.8		pF
Total Gate Charge	Qg			9.5		nC
Gate-Source Charge	Q _{gs}	V_{DS} =350 V , I_{D} =3 A ,		4.2		nC
Gate-Drain Charge	Q_{gd}	V _{GS} =10V		2.8		nC
Gate plateau voltage	Vgp			7		V
Switching times				•		
Turn-on Delay Time	t _{d(on)}			8		nS
Turn-on Rise Time	tr	V_{DD} =380 V , I_{D} =3 A ,		9		nS
Turn-Off Delay Time	t _{d(off)}	R_G =4 Ω , V_{GS} =10 V		40		nS
Turn-Off Fall Time	t _f			9		nS
Source- Drain Diode Characteristics						
Source-drain current(Body Diode)	I _{SD}	T 0500			6.3	Α
Pulsed-Source-drain current(Body Diode)	I _{SDM}	T _C =25°C			18.9	Α
Forward on voltage	V _{SD}	Tj=25°C,I _{SD} =6.3A,V _{GS} =0V		1.0	1.2	V
Reverse Recovery Time	t _{rr}			100		nS
Reverse Recovery Charge	Q _{rr}	Tj=25°C,lF3A,		0.35		uC
Peak reverse recovery current	I _{rrm}	di/dt=100A/µs		7		Α

Notes: 1. Repetitive Rating: Pulse width limited by maximum junction temperature

2. Tj=25 $^{\circ}\text{C}$,VDD=50V,VG=10V, RG=25 Ω



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS (curves)

Figure 1. Safe operating area

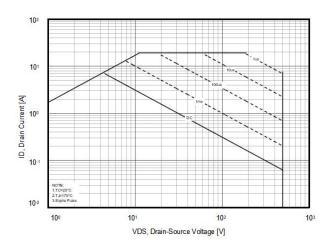


Figure 3. Output characteristics

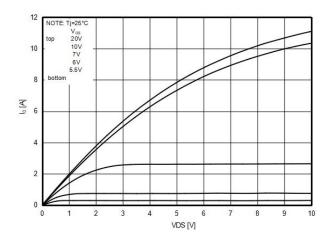


Figure 5. Static drain-source on resistance

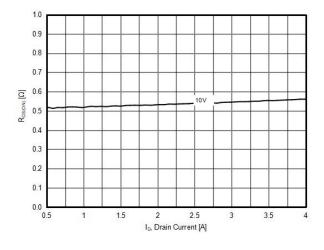


Figure 2. Source-Drain Diode Forward Voltage



Figure 4. Transfer characteristics

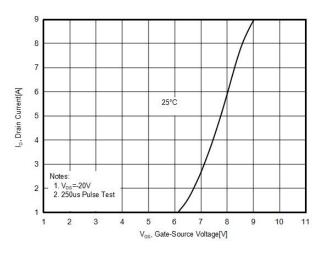


Figure 6. RDS(ON) vs Junction Temperature

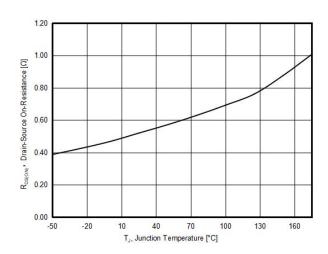




Figure 7. BV_{DSS} vs Junction Temperature

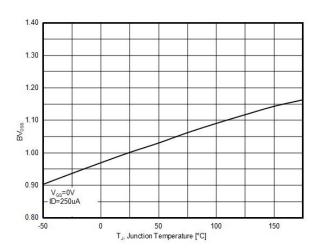


Figure 8. Maximum ID vs Junction Temperature

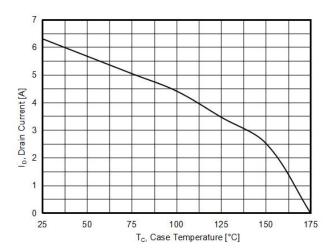


Figure 9. Gate charge waveforms

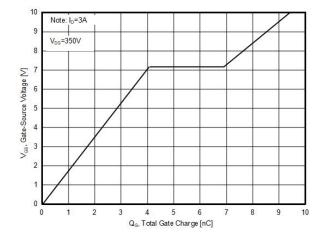
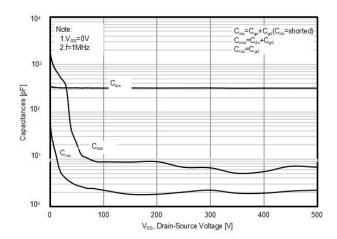


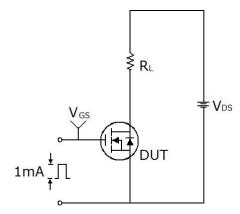
Figure 10. Capacitance

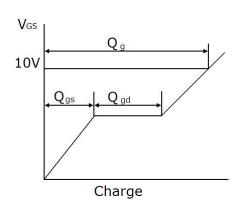




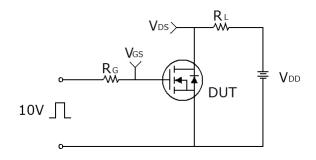
Test circuit

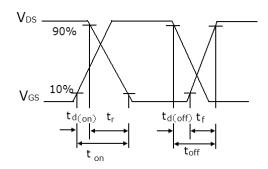
1) Gate charge test circuit & Waveform



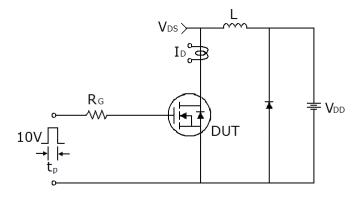


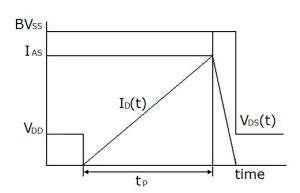
2) Switch Time Test Circuit:





3) Unclamped Inductive Switching Test Circuit & Waveforms

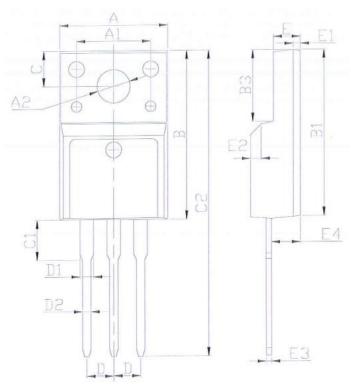




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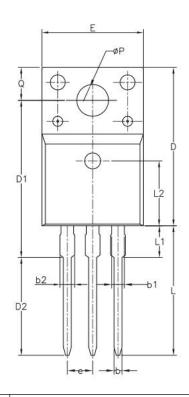
TO-220F-3L-L Package Information

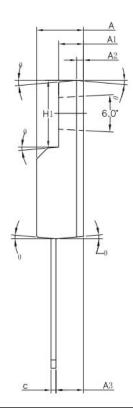


Symbol	Dimensions	In Millimeters	Dimensions	s In Inches
	Min.	Max.	Min.	Max.
А	9.86	10.46	0.387	0.411
A1	6.80	7.20	0.267	0.283
A2	2.92	3.32	0.115	0.130
A3	9.40	10.00	0.369	0.393
В	15.40	16.40	0.605	0.644
B1	15.10	16.10	0.593	0.633
B2	4.40	5.00	0.173	0.196
В3	6.40	7.00	0.251	0.275
С	3.05	3.55	0.120	0.139
C1	2.95	3.55	0.116	0.139
C2	28.20	29.20	1.108	1.147
D	2.54	1 BSC	0.100 BSC	
D1		1.47		0.058
D2	0.60	1.00	0.024	0.039
E	2.30	2.80	0.090	0.110
E1	0.45	0.95	0.018	0.037
E2	45.0°		45.00°	
E3	0.30	0.70	0.012	0.028
E4	2.45	3.05	0.096	0.120



TO-220F-3L-P Package Information





Symbol	Dimensions	In Millimeters	Dimension	s In Inches
	Min.	Max.	Min.	Max.
А	4.50	4.83	0.177	0.190
A1	2.34	2.74	0.092	0.108
A2	0.70) REF	0.028	3 REF
A3	2.56	2.93	0.101	0.115
b	0.70	0.90	0.028	0.035
b1	1.18	1.38	0.046	0.054
b2	-	1.47		0.058
С	0.45	0.60	0.018	0.024
D	15.67	16.07	0.616	0.631
D1	15.55	15.95	0.611	0.627
D2	9.60	10.00	0.377	0.393
E	9.96	10.36	0.391	0.407
е	2.54	4 BSC 0.100 BSC) BSC
H1	6.48	6.88	0.255	0.270
L	12.68	13.28	0.498	0.522
L1	-	3.50		0.138
L2	6.50	6.50 REF		5 REF
Ø P	3.08	3.28	0.121	0.129
Q	3.20	3.40	0.126	0.134



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